

Technical Construction File

For

Kaer Technology Co.,Ltd.

Terminal

Model:

SV,RV,FDD,MDD,E,TE,EN,SNB,RNB,DBN,PIN,BN,L-BN,TPT,MPD,FRD,FDFD,PBDD,PTV,DB V,BV,V,LSV,HV,FSV,LBV,ESV,ERV,EFDD,EMDD,EPTV,EDBV,BNY,FLDNY,FDFN,FDFNY,M DFN,MDFNY,SC,JG,GTY,C45,DTG,DTS,OT,DT,DL,GT-G,GL-G,DTL,DTL-2,DTL-5,JG-2,GTL,S C(JGY),SC(JGB),AUS,DIN GTY,DIN DL,JBL,JBT,JB-TL,T/J,CAPG,APG,CCT,CCA,WCJB,JM,JJC,CAU,CAL,CAPTAU,MJPB,MJPT,MJ PTN,GPH,LYF

- Prepared For : Kaer Technology Co.,Ltd. No.230, Wei 20th Road, Yueqing Economic Development Zone, Zhejiang Province, China
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TEST REPORT DECLARATION

Applicant	:	Kaer Technology Co.,Ltd.
Address	:	No.230, Wei 20th Road, Yueqing Economic Development Zone, Zhejiang Province, China
Manufacturer	:	Kaer Technology Co.,Ltd.
Address	:	No.230, Wei 20th Road, Yueqing Economic Development Zone, Zhejiang Province, China
EUT Description	:	Terminal
Model No.	:	SV
Remark	:	N/A

Test Procedure Used: EN IEC 61238-1-1:2019

The results of this test report are only valid for the mentioned equipment under test. The test report with all its sub-reports, e.g. tables, photographs and drawings, is copyrighted. Unauthorized utilization, especially without permission of the test laboratory, is not allowed and punishable. For copying parts of the test report, a written permission by the test laboratory is needed.

The test results of this report relate only to the tested sample identified in this report.

Date of Test : Apr.29, 2024

Prepared by (Jack) Checked b (Gina) Approved by : in l (Johnson)



	EN IEC 61238-1-1:2019				
Clause	Requirement-Test	Result-Remark	Verdict		
1	Scope		Р		
	This part of IEC 61 238 appl ies to compression		P		
	and mechanical connectors for power cables				
	for rated vol tages up to $1 \text{ kV} (\text{Um} = 1, 2 \text{ kV})$,				
	for example buried cables or cables instal led in				
	bui ld ings, having				
	a) conductors complying with IEC 60228 having				
	nominal cross-sectional areas between				
	2, 5 mm2 and 1 200 mm2 for copper and between				
	1 6 mm2 and 1 200 mm2 for aluminium;				
	b) a maximum continuous conductor temperature				
	not exceeding 90 °C.				
	This document is not appl icable to connectors for				
	overhead l ine cond uctors nor to connectors				
	wi th a sl iding contact.				
	The object of this document is to define the type				
	test methods and requi rements which appl y				
	to compression and mechanical connectors for				
	power cables wi th copper or aluminium				
	cond uctors. The reference method is to perform				
	the tests on unused conductors.				
2	Normative references		Р		
	The fol lowing documents are referred to in the		Р		
	text in such a way that some or al l of thei r				
	content consti tutes requi rements of this				
	document. For dated references, only the edition				
	ci ted appl ies. For undated references, the latest				
	ed i tion of the referenced document (includ ing				
	an y amendments) appl ies.				
3	Terms and defini tions		Р		
	For the purposes of this document, the terms and		Р		
	defini tions given in IEC 60050-461 and the				
	fol lowing appl y.				
	ISO and IEC maintain terminological databases				
	for use in standardization at the fol lowing				
	addresses:				
	• IEC Electroped ia: avai lable at http://www.				
	electropedia.org/				
	• ISO Onl ine browsing platform: avai lable at				
	http://www.iso.org/obp				
4	Symbols		Р		



	-	EN IEC 61238-1-1:20	19					
Clause		Requirement-Test	Result-Remark	Verdict				
	Α	nominal cross-sectional area of the conductor		Р				
	D	change in the resistance factor of the connector						
	Ι	I direct current flowing through a connection during resistance measurement I _{RMS} equivalent RMS short-circuit current						
	IRMS							
	I _N	alternating current necessary to maintain t equilibrium temperature	the reference conductor at its					
	I _r	direct current flowing through the reference resistance measurement	ce conductor/conductors during					
	k	connector resistance factor: ratio of the resista resistance of the equivalent length of the reference	nce of a connector to that of the nce conductor					
	k ₀	initial connector resistance factor: ratio of the re the resistance of the equivalent length of the ref	esistance of a connector to that of erence conductor at cycle no. 0					
	l _a , l _b , l _j	lengths of each connector assembly associated in the test setup after installation	with the measurement positions					
	l _r	length of the reference conductor between meas	surement positions					
	R	measured resistance value of connector/conductor corrected to 20 °C	r installation under an electrical test					
	R _r	measured resistance value of the reference conduct	or corrected to 20 °C					
	Rj	length related calculated resistance value of a corrected to 20 °C	connector under an electrical test					
	<i>t</i> ₁	heating time						
	 time necessary for the connectors and the reference conductor to cool to a value equal to or less than 35 °C potential difference between measurement positions while current <i>I</i> is applied 							
	$U_{\rm r}$ potential difference between measurement positions on a reference conductor while current $I_{\rm r}$ is applied							
	α temperature coefficient of resistance at 20 °C							
	β	mean scatter of the connector resistance factors						
	δ	initial scatter of the connector resistance factors						
	λ	resistance factor ratio: the actual resistance the measurement stage divided by its initial resistan	factor of the connector at each ce factor					
	θ	temperature of a connector						
	θ_{\max}	maximum temperature recorded on a connect during heat cycling	or over the total period of test					
	θ_{R}	temperature of the reference conductor determin	ned in the first heat cycle					
	θ_{ref}	temperature of the related reference conducto $\theta_{\rm max}$	or at the moment of measuring					
5	General			Р				
5.1	Defini ti	on of classes		Р				
	Al thoug the servi fol lowir a) Electr Class A These a distribut they can relativel conseque the majo Class B	gh i t is not possible to define precisel y ce condi tions for al l appl ications, the ng requi rements have been identi fied. ical requi rements: re connectors intended for electrici ty ion or ind ustrial networks in which n be subjected to short-ci rcui ts of y high intensi ty and duration. As a ence, Class A connectors are sui table for ri ty of appl ications.		Р				
	overload	s or short-ci rcui ts are rapidly cleared						



	EN IEC 61238-1-1:2019				
Clause	Requirement-Test	Result-Remark	Verdict		
Clause	EN IEC 61238-1-1:20 Requirement-Test by the instal led protective devices, for example fast-acting fuses. b) Mechanical requi rements: Class 0 Connectors subjected to practical 1 y no mechanical pul 1 -out force. These are for example, connectors inside swi tchgear where the cable or conductors are secured or anchored. Class 1 Connectors subjected to a mechanical pul 1 -out force related to the conductor nominal cross-sectional area and material (according to Table 4) but 1 imi ted to a 20 kN pul 1 -out force. These are for example connectors for underground cable joints. Class 2 Connectors subjected to a mechanical pul 1 -out	19 Result-Remark	Verdict		
	Connectors subjected to a mechanical pull 1-out force above 20 kN and related to the cond uctor nominal cross-sectional area and material (according to Table 4). This Class 2 is only appl icable to conductor nominal cross-sectional areas $\geq 400 \text{ mm2}$ for copper and $\geq 630 \text{ mm2}$ for aluminium. These are for example connectors in cable instal lations where thermomechanical forces are estimated to exceed 20 kN. Hence, the five classes correspond to the fol lowing tests: Class A: heat cycl ing and short-ci rcui t tests; Class B: heat cycl ing test onl y; Class 0: no mechanical test; Class 1: mechanical test wi th 1 imi ted maximum tensi le force; Class 2: mechanical test wi th no maximum tensi le force.				
5.2	 Conductor The fol lowing information shal 1 be recorded in the test report: cond uctor material; nominal cross-sectional area, dimensions and shape; detai 1 of conductor construction shal 1 be given when known, or can be determined by inspection, for example: class according to IEC 60228 (sol id, stranded and flexible); compacted or non-compacted for stranded conductor; number and arrangement of strands; type of plating, if appl icable; type of impregnation, water blocking, etc., i f appl icable. 		P		
5.3	Connectors and instal lation procedure		Р		
-	The fol lowing information shal l be recorded in the test report:		Р		



	EN IEC 61238-1-1:20	19	
Clause	Requirement-Test	Result-Remark	Verdict
	- the assembly method or the instal lation		
	instruction that is to be used;		
	- tool ing, dies and an y necessary setting;		
	- i f not part of the del ivered prod uct, for		
	example at cable conductor termination: bol ts,		
	nuts,		
	washers, lubricant, torque, etc. ;		
	- preparation of contact surfaces, i f appl icable,		
	for example cleaning, brushing and/or		
	greasing of inner and/or outer cond uctor and/or		
	connector surfaces;		
	- identi fication of the connector, for example		
	name of the supplier, drawing, reference		
	number, type.		_
5.4	Range of approval		Р
	In general, tests made on one type of		Р
	connector/cond uctor combination apply to that		
	arrangement onl y. However, to l imi t the number		
	of tests, when using the same conductor		
	material, the fol lowing is permi tted:		
	- a connector which can be used on stranded		
	round cond uctors or on stranded sectorshaped		
	conductors which have been rounded, is approved		
	for both types 1 f satisfactory		
	resul is are obtained on a compacted round cond		
	uctor;		
	- a connector which covers a range of		
	consecutive cross-sectional areas shall be		
	i f satisfactory results are obtained on the small		
	lest and the largest cross-sectional areas:		
	- if a connector is a through connector for two		
	conductors of d i fferent cross-sectional areas		
	shapes or materials and if the jointing method		
	and the connector barrels used have		
	al read v been tested separatel v for each		
	cross-sectional area. no add i tional test is		
	necessary. I f not, and i f i t is required for		
	bimetal l ic through connectors, ad di tional tests		
	shal 1 be made using the conductor having the		
	highest temperature of the two conductors,		
	as reference conductor;		
	- i f a type test for a range taking mechanical		
	connector is passed on the biggest possible		
	conductor cross-sectional area, this resul t is also		
	val id for simi lar connector designs wi th		
	the same material of the connector bod y but		
	bigger outer diameter provided that the		
	design of the conductor clamping channel (inner		
	diameter, shape, etc.), quanti ty and design of		
	clamping screws (torque, material, size, shear-off		
	characteristic, etc.) are		
	identical;		
	- 1 I a manufacturer can clearly demonstrate		
	that common and relevant connector design		
	cri teria were used for a fami I y of connectors,		



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Clause	Requirement-Test	Result-Remark	Verdict
	conformi ty to this document is achieved by		
	successful l y testing the largest, the smal lest and		
	two intermediate connector sizes;		
	exception no. 1 : for a fami ly of connectors		
	consisting of five sizes, only the largest		
	connector, the smal lest connector, and one		
	connector of a representative intermediate		
	size need to be tested;		
	exception no. 2: for a fami ly of connectors		
	consisting of four sizes or less, only the		
	largest connector and the smal lest connector		
	need to be tested;		
	- i f conformi ty to this document is achieved		
	by successful 1 y testing a connector on a dry		
	conductor then approval is achieved for the same		
	cond uctor used in an impregnated paper		
	insulated cable;		
	- for connectors where one or both sides are		
	designed for a range of cross-sectional areas,		
	and a common clamping or crimping arrangement		
	serves for the connection of the		
	di fferent cross-sectional areas, then mechanical		
	tests on conductors wi th the largest and		
	smal lest cross-sectional areas shal 1 be carried		
	out accord ing to Clause 7 for connectors		
	accord ing to Class 1 or Class 2;		
	- i f conformi ty to this document is achieved		
	by successful 1 y testing a mechanical connector		
	on round stranded aluminium conductors, this		
	type test approval can be applied to sol id		
	aluminium cond uctors of the same		
	cross-sectional area(s);		
	- i f conformi ty to this document is achieved		
	by successful testing of a through connector,		
	this type test approval can apply to the barrel of a		
	termination which uses the same design		
	cri teria. Approval of the complete termination		
	can be achieved if the termination		
	connection does not influence the barrel		
	performance, proven through design parameters.		
	drawings or through thermal veri fication tests:		
	- i f conformi ty to this document is achieved		
	by successful 1 v testing a connector on a		
	conductor wi th water blocking, approval is		
	achieved for the same conductor wi thout an v		
	water blocking but not for the same conductor wi		
	th di fferent types of water blocking :		
	- if conformity to IEC 61 238-1 -3 is achieved		
	by successful 1 y testing a connector approval is		
	achieved for the same classes and conductors in		
	this document.		
6	Electrical tests		D
0			
6.1	Instal lation		Р
	6.1.1 General		P
	Al I conductors of the same nominal		
	cross-sectional area in the test loop shal I be taken		



	EN IEC 61238-1-1:20	19	1
Clause	Requirement-Test	Result-Remark	Verdict
	from the same conductor length.		
	For each series of tests, six connectors shall be		
	instal led in accordance with the		
	inanulacturer's instructions, on a bare conductor		
	removed before assembly to form a test loop		
	together with the corresponding reference		
	conductor		
	For stranded conductors poten tial di fferences		
	between the strands at potential measuring		
	posi tions can cause errors in measuring electrical		
	resistance. Equal izers according to		
	Annex A shal I be used to overcome this problem		
	and to ensure uni form current d istribution in		
	the reference conductor and between connectors		
	at the equal izer posi tions. The		
	recommended method is to prepare equal izers on		
	the test loop before instal I ing connectors.		
	The test loop shall be installed in a location		
	The ambient temperature of the text location shall		
	The amblent temperature of the test location shart $1 = 15 \text{ °C}$ and 30 °C		
	For conductor cross-sectional areas above 1 000		
	mm2, it is allowed to increase the ambient		
	temperature range of the test location between 1.5		
	°C and 40 °C. At the end of the cool ing		
	phase the ambient temperature shal 1 be between		
	1 5 °C and 30 °C.		
	I n the case of sol id conductors, the potential		
	measuring positions shall be as close as		
	possible to the connector in order to red uce la		
	and 10 close to zero. The test loop may be of an y shape according to		
	Figure 2 or Figure 3 provided that it is		
	arranged in such a way that there is no adverse		
	effect from the floor, wal is and cei ling, other		
	test loops and adjacent test branches.		
	To faci l i tate the short-ci rcui t test for		
	connectors according to Class A, the loop may be		
	d isassembled as shown in Figure 2 b) . I n this		
	case, the sectioning connections shall not		
	influence the temperatures of the test objects		
	during heating.		
	Relignmening of bol ts or screws of the connectors		
	under test is not permitted.		D
	6. 1.2 Inrough connectors and terminations		Р
	The test loop shown in Figure 2 indicates the		
	dimensions that shall be used.		
	Where terminal lugs or mechanical connectors for		
	terminal bars are to be tested, they shal l be		
	bol ted to l inking bars in accordance wi th the		
	manufacturer's instructions or other relevant		
	standards/speci fications defining methods and		
	instructions for fastening terminations. These		



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Clause	Requirement-Test	Result-Remark	Verdict			
	l inking bars shal l, at the point of connection, be					
	of the same dimensions and thickness as the					
	palm, and also of the same material.					
	I t may be necessary to adjust the thermal					
	characteristics of the l inking bar outside the point					
	of connection, to achieve the temperatures speci					
	fied in 6. 3.					
	For terminal lugs, the u se of l inking bars is the					
	recommended test method al though i t is					
	al ternativel y possible to test terminal lugs with					
	palms connected di rectl y to palms.					
	I f i t is requested that the terminal lug test					
	includes an evaluation of the performance of the					
	bol ted palm when connected to a speci fied plant					
	terminal, then the linking bar method shall be					
	used and the l inking bar ends, or an intermediate					
	piece, shal l be defined and described in					
	material, size and surface coating.					
	6. 1 .3 Branch connectors		Р			
	When the branch connector is intended for a					
	branch nominal cross-sectional area equal to the					
	immediatel y above or below the main it is					
	treated as					
	a through connector between the main and the					
	branch, and the test method for through					
	connectors as shown in Figure 2 is appl icable. I n					
	other cases, the test loop shall be as shown					
	In Figure 3. Where a type of connector makes 1 t					
	that part of the connector which acts as a through					
	connector shall also be tested as for					
	through connectors.					
6.2	Measurements		Р			
0.2	6.2.1 General		P			
	Measurements shal 1 be made at stages		I			
	throughout the test according to Table 2.					
	6.2.2 Electrical resistance measurements		Р			
	The resistance measurements shall be made					
	under stead y temperature condi tions of both the					
	test loop and test location. The ambient					
	temperature shal 1 be between 1 5 °C and 30 °C.					
	The recommended method is to pass a di rect					
	current of up to 1 0 % of the estimated heat					
	cycl ing current, through the connectors and the					
	reference conductor, wi thout signi ficantly					
	increasing the temperature and to measure the					
	potential di fference between two speci fic					
	potential measuring posi tions. The ratio of					
	potential di fference and d i rect current is the					
	electrical resistance between those two posi tions.					



	EN IEC 61238-1-1:20	19	
Clause	Requirement-Test	Result-Remark	Verdict
	To decrease the uncertainty of the resistance		
	measurement, i t is recommended that the di rect		
	current is adjusted to the same value throughout		
	the electrical test.		
	For branch conductors assembled in accordance		
	wi th Figure 4, the whole of the measuring		
	current shal I flow through that part of the		
	connector whose potential d i fference is being		
	measured. Swi tches or d isconnecting terminals		
	may be provided for this purpose.		
	Thermoelectric vol tages may affect the		
	uncertainty of low resistance measurements (of		
	theorder of 1 0 $\mu\Omega$). I f this is suspected, the		
	recommended method is to take two resistance		
	measurements wi th the di rect measuring current		
	reversed between readings. The mean of the		
	two read ings is then the actual resistance of the		
	sample.		
	The potential measuring positions shall be as		
	indicated in Figure 4 and Annex B. The various		
	lengths shall be measured individual ly to enable		
	the actual connector resistances to be		
	determined. The temperature of connector and		
	reference conductor shall be recorded when		
	resistance measurements are made. For d i rect		
	comparison, the resistance values shall be		
	corrected to 20 °C. I nformation on the		
	recommended method is also given in An nex B.		
	Temperature measurements at these positions		
	shall be made during the heat cycling test.		
	Ind i rect resistance readings:		
	- vol tage measurements shall have a device		
	uncertainty within $\pm 0.5\%$ or ± 1.0 µV by		
	taking $(1, 0, 0, 0, 0, 0, 0, 0, 0, 0, 0, 0, 0, 0,$		
	the greater value.		
	- current measurements shall have a device		
	$\frac{1}{10000000000000000000000000000000000$		
	the greater value $\pm 0, 5\%$ of $\pm 0, 1$ A, by taking		
	Di roct registance readinge:		
	Di lect lesistance leaunigs.		
	Resistance measurements shart have a device uncortainty within $\pm 1.\%$ or $\pm 0.5 \pm 0.5$ µO by taking		
	the greater value when the instrument is cal		
	ibrated against a certi fied standard resistance		
	6 2 3 Temperature measurements		D
	Temperatures of both connectors and reference		Г
	conductors shall be massured at the		
	positions indicated in Figure 4. The		
	recommended method of temperature		
	monosurement is to		



	EN IEC 61238-1-1:20	19	
Clause	Requirement-Test	Result-Remark	Verdict
	use thermocouples. The temperature		
	measurements shal I have a device uncertainty wi		
	thin ± 2 K		
63	Heat cycl ing test		D
0.5	62 1 Concept		
	0.5. I General The best eval ing test shall be made with all		Р
	tornating current		
	6.3.2 First hast avala		D
	The object of the first heat cycle is to determine		P
	the reference conductor temperature to be		
	used for subsequent cycles and also to identi fy		
	the med ian connector (see 3, 1, 2) at		
	equi l ibrium.		
	Equi l ibrium is reached when the reference		
	conductor and the connectors do not vary in		
	temperature by more than ± 2 K during appl		
	ication of the heating current. Minimum periods		
	tomaintain temperature stabi 1 i ty are defined in		
	Table 1.		
	a) Through connectors and terminations		
	Current is circulated in the test loop, bringing the		
	reference conductor to 1 20 °C at equi l ibrium.		
	I the temperature of the median connector is		
	equal to or greater than 1 00 °C, the reference		
	conductor temperature for subsequent neat cycles $abal 1 ba daemad to ba 1.20 ^{\circ}C$. If not, then		
	the current shall be increased until the med ian		
	connector temperature reaches 1.00 °C at		
	equi 1 ibrium, subject to the reference cond uctor		
	temperature not exceeding 1 40 °C. I f the		
	temperature of the median connector does not		
	reach 1 00 °C, even wi th a reference conductor		
	temperature of 1 40 °C, the test shal 1 be		
	continued at that temperature. The measured		
	reference conductor temperature θ R shal 1 then		
	be used for subsequent heat cycles		
	$(1\ 20 \ \circ \ \mathbf{C} \leqslant \ \theta \ \mathbf{R} \leqslant 1\ 40 \ \circ \ \mathbf{C}).$		
	Where I inking bars are used for terminal lugs, the		
	temperature at the midpoint of the bar		
	I inking the paims should also be measured. This		
	the reference conductor $A \mathbf{P}$ with a telerance of		
	+5 K		
	LJ R. b) Branch connectors		
	Where it is necessary to use the circuit shown in		
	Figure 3, current shall be circulated in the		
	test loop, bringing the main reference conductor		
	and the three branch reference conductors to		
	1 20 °C at equi 1 ibrium. To achieve this, the		
	currents in the three branches shal 1 be adjusted		
	bycurrent injection or impedance control. I f the		
	temperature of the median connector according		
	to defini tion 3. 1 2 is then equal to or greater than		
	1 00 °C, the reference conductor temperature		



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Clause	Requi	irement-T	'est		Result-R	emark	Verdict
	for subsequent heat cycles shal l be deemed to be						
	1 20 °C. I f not, then the current shal l be						
	increased in the loop	unti I the 1	med ian con	nector			
	provided the reference	00°C al e	equi l'ibriun	l,			
	$1.40 ^{\circ}\text{C}$ It may be ne	cessary at	this stage	exceeu			
	and also at intervals f	hroughout	the test to	adi ust			
	the current in an ind i	vidual brai	nch so as to	aaj ast			
	ensure that each bran	hch referer	nce tempera	ture is			
	the same as the main	reference	1				
	temperature wi th a	a toleranc	e of ± 2 K	. The			
	measured reference co	ond uctor t	temperature	θR on			
	the main and branch	conducto	ors, shal l tl	nen be			
	used for subsequent h	eat cycles	°				
	$(120 C \leq \theta R)$	≈ 140	C).				
	Tab	le 1 – Minim	num period of	temperature	stability		Р
	Nominal conductor cross-	for a l uminium:	$A \leq 300$	300 < <i>A</i> ≤ 630	$630 < A \le 1\ 000$	A > 1 000	
	sectional area A (mm ²)	for copper:	$A \leq 240$	240 < <i>A</i> ≤ 400	$400 < A \le 800$	A > 800	
	Minimum period (min)		15	20	30	60	
	(220 11 /	1					
	6.3.3 Second heat cyc		1 • /				Р
	The object of this second	ond heat c	ycle is to				
	determine the heat cy	cle duratio	on and tempe	erature			
	profi le which wi l l b	e used on	the test loop	for al			
	I subsequent heat cycl	les. Curren	it is ci reulat	ted			
	in the loop until the r	nain refere	ence cond uc	tor			
	temperature reaches the	he value θ	R determine	ed in			
	6. 3. 2, wi th a tolerance of $0+6K$ and the median						
	connector temperature	e is stable	wi thin a ba	nd			
	of 2 K over a 1 0 min	period and	d does not d	i ffer			
	by more than 3 K con	pared to t	he temperat	ure			
	measured during the f	ï rst heat c	cycle.				
	For branch connectors	s that need	l to use the c	rcui			
	t shown in Figure 3, c	urrent is c	i rculated in				
	the loop unti l the brai	nch referen	nce cond uc	tor			
	temperature reaches the	he value θ	R determin	ed in			
	6. 3. 2, wi th a toleran	ce of 0+61	K and the m	ain			
	reference conductor te	emperature	e reaches the	e			
	value θ R determined	in 6.3.2, v	vi th a tolera	nce of			
	46-+K. The median c	onnector t	temperature	is			
	stable wi thin a band	of 2 K ove	er a 1 0 min j	period			
	and does not d i ffer b	y more that	an 3 K				
	compared to the temp	erature me	easured d ur	ing			
	the fi rst heat cycle.						
	At the beginning of th	he heat cyc	ele, an eleva	ted			
	current up to 1 50 % of	of IN may	be used as t	he			
	preferred method, to r	ed uce the	heating per	iod.			
	The current shal I then	eafter be o	decreased or	.			
	regulated to a mean v	alue of the	e current clo	se to			
	IN to ensure stable co	nd i tions	during the				



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Clause	Requirement-Test Result-Remark	Verdict			
Clause	Requirement-TestResult-Remarkmedian-connector control period. I t may be necessary to use more than one cycle to determine the second heat cycle.It may be necessary to use more than one cycle to determine the second heat cycle.The reference conductor temperature shal 1 be the control parameter, in order to keep the temperature profi le during the heat cycl ing test. I n this way, the fluctuation of the ambient temperature wi 1 not affect the temperature profi le of the reference conductor wi thin the tolerances given in this document.The determined heating profi le of the reference conductor containing the characteristics of temperatures during time, as shown in Figure 1 , shal 1 be recorded and reproduced for al 1 subsequent heat cycles.The heating period t1 is fol lowed by a cool ing period t2 to bring the temperatures of al 1 connectors and the reference conductor to values $\leq 35 ^{\circ}$ C.I t may be necessary in subsequent heat cycles to adjust t2 to ensure that the temperature condi tions are reached, in particular during the measurement of resistances in order to respect the condi tions of 6. 2. 2.I f accelerated cool ing is used , i t shal 1 act on the whole of the loop, and use ai r wi thin ambient temperature 1 imits.	Verdict			
	(see Figure 1).	P			



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Clause	Requirement-Test		Result-Remark	Verdict
	6.3.4 Subsequent heat cycles A total of 1 000 heat cycles shal 1 be made according to 6. 3.3. After the cool ing period of the			Р
	cycles indicated in Table 2, the resistanc	e and		
	reference conductor shall be recorded as	s		
	described in 6. 2. The maximum temperature	ature of		
	each	6 1		
	lowing the resistance measurements shall	or fol l l also be		
	Table 2 – Electrical resistance mea	surements d	luring the electrical test	Р
	Class A		Class B	
	cycle no. 0, before the first heat cycle, see 6.3.2	cycle no. 0, be	efore the first heat cycle, see 6.3.2	
	after cycle no. 200 before short-circuit test			
	after cycle no. 200 and after short-circuit test			
	after cycle no. 250°	after cycle no.	. 250 ^a	
	(in total 14 measurements)	(in total 12 me	easurements)	
	 A tolerance of ±10 cycles may be used for collecting 	measurements		
6.4	Short-ci rcui t test for connectors acc	cording to		Р
	Class A	0		
	6.4. 1 General			Р
	The short-ci rcui t test shal l be made wi	th al		
	ternating current.			
	After finishing 200 heat cycles, six short	t-ci rcui t		
	currents shal I be appl ied on each conne	ector.		
	After each short-ci rcui t current appl ica	ation, the		
	test loop shal l be cooled to a temperatur	re		
	≤ 35 ° C.			
	The measured ini tial reference cond uct	or		
	temperature, the current and the duration	n, as wel l		
	as the J oule integral of each short-ci rcu	i t current		
	application shall be recorded in the test			
	report	-		
	When through connectors are used to co	nnect di		
	fferent conductors in the same test, the	inteet ui		
	conductor with the highest nominal elec	etrical		
	resistance per uni t length shall be used	25		
	reference conductor	ub		
	When branch connectors are used, the sl	nort_ci		
	roui t current shall be applied from the	main		
	acord vator to the branch and better f	niani		
	conductor to the branch conductor for e	acm		
	connector under test.			
	As stated in 6.1.1 the test loop may be			



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Clause	Requirement-Test	Result-Remark	Verdict		
	disassembled for this test. Since the short-ci rcui t				
	test				
	is intended to reproduce the thermal effects of				
	high currents onl y, the recommended method				
	is to use a concentric return conductor in order to				
	reduce the electro-d ynamic forces. The test				
	arrangements shal I be described in the test report.				
	For aluminium conductor nominal cross-sections				
	> 400 mm2 and for copper $> 300 mm2$,				
	preheating				
	up to 90 °C may be used. However, for nominal				
	cross-sectional areas exceeding				
	630 mm2 for copper or 1 000 mm2 for				
	aluminium, the defined parameters (45 kA and 5				
	s) are				
	insufficient to reach 250 °C.				
	When determining the short-ci rcui t current RMS				
	value, a device taking into account the DC				
	component should be used. Al ternatively, the				
	determination of I2t can be obtained using the				
	method described in Annex E, noting this method				
	does not take into account the DC				
	component of the current.				
	6.4.2 Aluminium conductors wi th cross-sectional		Р		
	areas below 1 000 mm2 and copper				
	conductors with cross-sectional areas below 630				
	mm2				
	The short-ci rcui t test current level shal l be such,				
	that i t raises the reference cond uctor from a				
	temperature ≤ 35 ° C to a temperature				
	between 250 $^{\circ}$ C and 270 $^{\circ}$ C.				
	The duration of the short-ci rcui t test current shal				
	l be (0 51 0 1,,+-) s wi th a maximum current of				
	25 kA.				
	I f the requi red short-ci rcui t test current exceeds				
	this value, a longer duration ≤ 5 s wi th a				
	current between 25 kA and 45 kA shal l be used.				
	The minimal appl icable adiabatic J oule integral				
	I2ADt, which raises the temperature of the				
	reference cond uctor to 250° C, shal l be				
	calculated accord ing to the formula in Annex D,				
	aswel I as the maximum appl icable ad iabatic				



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Clause	Requirement-Test	Result-Remark	Verdict	
	Joule integral I2ADt necessary to reach a final			
	temperature of 270 °C.			
	The adiabatic J oule integral I2ADt used for each			
	short-ci rcui t current appl ication d uring the			
	short-ci rcui t test shal l be between both previous			
	calculated values of Joule integrals I2ADt.			
	6.4.3 Aluminium conductors wi th cross-sectional		Р	
	areas ≥ 1000 mm2 and copper			
	conductors wi th cross-sectional areas \geq 630			
	mm2			
	A short-ci rcui t test current of 45 kA for 5 s shal 1			
	be appl ied.			
6.5	Assessment of resul ts		Р	
	An ind ividual connector resistance factor k		Р	
	enables a common method of connector			
	assessment to be made over the range of			
	conductor cross-sectional areas appl icable to this			
	document. The parameters 1 isted below shal 1 be			
	calculated according to Annex F:			
	a) The connector resistance factor k shal l be			
	calculated according to Clause F.3, for each of			
	the six connectors at al 1 the measurement			
	intervals l isted in Table 2.			
	b) The ini tial scatter δ , between the six ini tial			
	values of k0, measured before heat cycl ing,			
	shal l be calculated accord ing to Clause F.4.			
	c) The mean scatter β , between the six values of			
	k, averaged over the last 1 1 measurement			
	intervals, shal 1 be calculated accord ing to Clause			
	F.5.			
	d) The change in resistance factor D for each of			
	the six connectors shal l be calculated			
	according to Clause F. 6. D is the change in the			
	value of k taken over the last			
	1 1 measurement intervals, calculated as a			
	fraction of the mean value of k in this interval ;			
	e) The resistance factor ratio λ shall be calculated			
	according to Clause F. 7.			
	f) The maximum temperature θ max on each			
	connector shal l be recorded according to			
	Clause F.8.			
6.6	Requi rements		Р	
1	I ▲		1	



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Clause	Requirement-T	Test	Re	sult-Remark	Verdict
	The six connectors shall satisfy the requirements			Р	
	shown in Table 3. I f one connector out of				
	the six does not satisfy one or more of the requi				
	rements, a re-test may be carrie	d out. I n this			
	event, al l six new connectors	s shal l satisfy	y the		
	requi rements.				
	I f more than one connector ou	it of the six do	o not		
	satisfy one or more of the requi	rements, no			
	re-test is permi tted and the type	e of connector	[·] shal		
	l be deemed as not conforming	to this			
	document.				
	Table 3 – Ele	ectrical test r	equirements		Р
	Parameter	Designation	Text reference	Maximum value	
	Initial scatter	δ	Clause F.4	0,30	
	Mean scatter	β	Clause F.5	0,30	
	Change in resistance factor	D	Clause F.6	0,15	
	Resistance factor ratio	λ	Clause F.7	2,0	
	Maximum temperature	θ_{\max}	Clause F.8	$\theta_{\rm ref}$	
	NOTE Specified values are base	ed on experience.			
67	Examples of electrical test lo	on configura	tions		P
0.7	and associated parameters	op comguiu	lions		-
	See Figures 2, 3 and 4.				P
		•	d 📕		Р
	$\geq d/2$				
			-00(
	a) Through connectors – principle test loop				











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Clause	Requirement-Test	Result-Remark	Verdict
	TC	Formulas:	Р
	Cu Al la laj lbj lb IEC	$R_{j} = R - \left(\frac{R_{r}Cu}{l_{r}Cu} \times l_{a} + \frac{R_{r}AI}{l_{r}AI} \times l_{b}\right)$ $k = \frac{R_{j}}{\frac{R_{r}Cu}{l_{r}Cu} \times l_{aj} + \frac{R_{r}AI}{l_{r}AI} \times l_{bj}}$	
	Re	eferences: copper and aluminium conductors	
	c) Bimetallic through conne	ector	_
		Formulas: $R_{j} = R - \left(\frac{R_{r} \text{main}}{l_{r} \text{main}} \times l_{a} + \frac{R_{r} \text{branch}}{l_{r} \text{branch}} \times l_{b}\right)$	Р
	тс	$k = \frac{R_{\rm j}}{R_{\rm r} {\rm branch}} \times \frac{l_{\rm r} {\rm branch}}{l_{\rm j}}$	
	d) Branch connector	References: main and branch conductors	
			Р
		Formulas: $R_{\rm j} = R - R_{\rm r} \times \frac{l_{\rm a}}{l_{\rm r}}$	
		$k = \frac{R_{\rm j}}{R_{\rm r}} \times \frac{l_{\rm r}}{l_{\rm j}}$	
	TC < L IEC e) Barrel of terminal lug	Reference: conductor	
		Formulas:	Р
		$R_{j} = R$ $k = \frac{R_{j}}{R_{r}} \times \frac{l_{r}}{l_{j}}$	
	IEC f) Palm of terminal lug	Reference: conductor	



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Clause	Requirement-Test	Result-Remark	Verdict
		ormulas: $R_j = R - R_r \times \frac{l_a}{l_r}$ $k = \frac{R_j}{R_r} \times \frac{l_r}{l_j}$ Reference: conductor	Р
	g) Connection to the conductor for a mechan	lical connector	
	h) Connection to a terminal bar for a mech Key TC = Temperature measurement positions Figure 4 – Typical cases of resistance	Formulas: $R_j = R$ $k = \frac{R_j}{R_r} \times \frac{l_r}{l_j}$ Reference: conductor hanical connector	Р
7	Mechanical test		Р
7.1	General		Р
	The purpose of this test is to ensure an acceptable		Р
	mechanical strength for the connections to		
	the conductors of power cables.		
7.2	Method		P
	The test shall be made on three ad difficult connectors having the same combination of cond uctors and instal lation proced ure as used for the electrical test. The recommended cond uctor length between connectors or between connector and tensi le test machine jaws is ≥ 500 mm. The rate of appl ication of the load shall not exceed 1 0 N per square millimeter of nominal cross-sectional area and per second up to 25% of the value in Table 4 in order to mark the conductor relatively to the connector, then up to the value in Table 4, which is then maintained for 1 min. The apple icable tolerance for applying the		r





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Clause	Requirement-Test	Result-Remark	Verdict	
	- instal lation for example in the case of			
	terminations, where bol ted connections are not			
	suppl ied and not described by the manufacturer,			
	for example palms of cable lugs, where			
	ad di tional information shal l be given about			
	material, surface and lubrication of used bol ts,			
	nuts, washers and appl ied torques;			
	- temperature measurement method (see 6. 2.			
	3);			
	- current IN at equi l ibrium temperature (see 6.			
	3. 2);			
	- for Class A the short-ci rcui t test parameters			
	(see 6. 4);			
	- test loop configuration;			
	- values and graph of the connector resistance			
	factor k versus the cycle number (see 6. 5);			
	- values and graph of the maximum			
	temperatures versus the cycle number (see 6. 3.			
	4);			
	- resul ts of the electrical test (see Table 3).			
	It is advisable to show a graph of the temperature			
	profi le of the second cycle (see 6. 3. 3).			
8.3	Mechanical test		Р	
	The test report shal I include the fol lowing		Р	
	information:			
	- connector class (see 5.1);			
	- conductor used (see 5. 2);			
	- connector and instal lation proced ure (see 5.			
	3);			
	- resul ts of the mechanical test.			
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Annex: Technical Information

(1) Product Photos



A.1







A.4